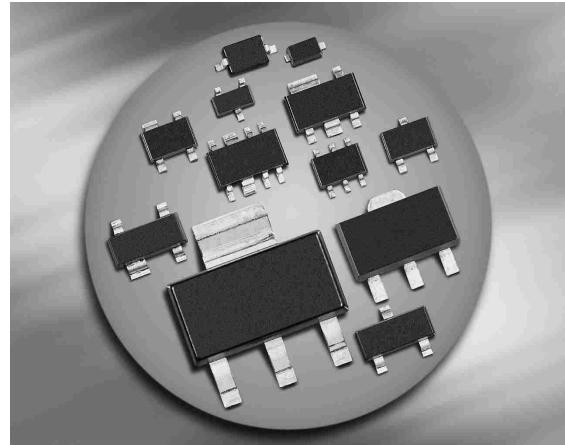


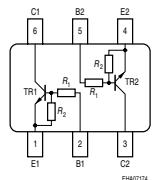
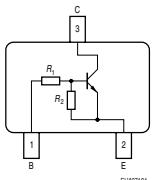
NPN Silicon Digital Transistor

- Switching circuit, inverter, interface circuit, driver circuit
- Built in bias resistor ($R_1=2.2\text{k}\Omega$, $R_2=47\text{k}\Omega$)
- For 6-PIN packages: two (galvanic) internal isolated transistors with good matching in one package



BCR108/F/L3
BCR108T/W

BCR108S
SEMH10



Type	Marking	Pin Configuration							Package
BCR108	WHs	1=B	2=E	3=C	-	-	-	-	SOT23
BCR108F	WHs	1=B	2=E	3=C	-	-	-	-	TSFP-3
BCR108L3	WH	1=B	2=E	3=C	-	-	-	-	TSLP-3-4
BCR108S	WHs	1=E1	2=B1	3=C2	4=E2	5=B2	6=C1	-	SOT363
BCR108T	WHs	1=B	2=E	3=C	-	-	-	-	SC75
BCR108W	WHs	1=B	2=E	3=C	-	-	-	-	SOT323
SEMH10	WH	1=E1	2=B1	3=C2	4=E2	5=B2	6=C1	-	SOT666

Maximum Ratings

Parameter	Symbol	Value	Unit
Collector-emitter voltage	V_{CEO}	50	V
Collector-base voltage	V_{CBO}	50	
Emitter-base voltage	V_{EBO}	5	
Input on voltage	$V_{i(on)}$	10	
Collector current	I_C	100	mA
Total power dissipation- BCR108, $T_S \leq 102^\circ\text{C}$ BCR108F, $T_S \leq 128^\circ\text{C}$ BCR108L3, $T_S \leq 135^\circ\text{C}$ BCR108S, $T_S \leq 115^\circ\text{C}$ BCR108T, $T_S \leq 109^\circ\text{C}$ BCR108W, $T_S \leq 124^\circ\text{C}$ SEMH10, $T_S \leq 75^\circ\text{C}$	P_{tot}	200 250 250 250 250 250 250	mW
Junction temperature	T_j	150	$^\circ\text{C}$
Storage temperature	T_{stg}	-65 ... 150	

Thermal Resistance

Parameter	Symbol	Value	Unit
Junction - soldering point ¹⁾ BCR108 BCR108F BCR108L3 BCR108S BCR108T BCR108W SEMH10	R_{thJS}	≤ 240 ≤ 90 ≤ 60 ≤ 140 ≤ 165 ≤ 105 ≤ 300	K/W

¹⁾For calculation of R_{thJA} please refer to Application Note Thermal Resistance

Electrical Characteristics at $T_A = 25^\circ\text{C}$, unless otherwise specified

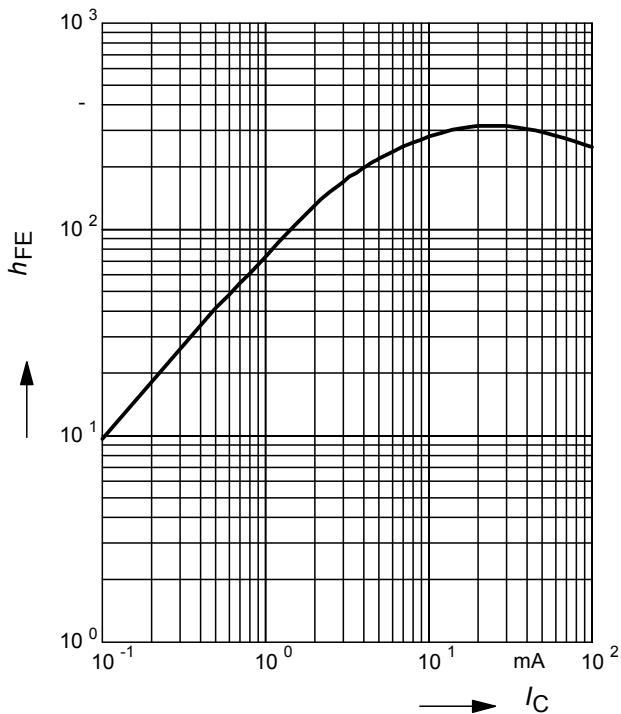
Parameter	Symbol	Values			Unit
		min.	typ.	max.	
DC Characteristics					
Collector-emitter breakdown voltage $I_C = 100 \mu\text{A}, I_B = 0$	$V_{(\text{BR})\text{CEO}}$	50	-	-	V
Collector-base breakdown voltage $I_C = 10 \mu\text{A}, I_E = 0$	$V_{(\text{BR})\text{CBO}}$	50	-	-	
Collector-base cutoff current $V_{CB} = 40 \text{ V}, I_E = 0$	I_{CBO}	-	-	100	nA
Emitter-base cutoff current $V_{EB} = 5 \text{ V}, I_C = 0$	I_{EBO}	-	-	164	μA
DC current gain ¹⁾ $I_C = 5 \text{ mA}, V_{CE} = 5 \text{ V}$	h_{FE}	70	-	-	-
Collector-emitter saturation voltage ¹⁾ $I_C = 10 \text{ mA}, I_B = 0.5 \text{ mA}$	V_{CEsat}	-	-	0.3	V
Input off voltage $I_C = 100 \mu\text{A}, V_{CE} = 5 \text{ V}$	$V_{i(\text{off})}$	0.4	-	0.8	
Input on voltage $I_C = 2 \text{ mA}, V_{CE} = 0.3 \text{ V}$	$V_{i(\text{on})}$	0.5	-	1.1	
Input resistor	R_1	1.5	2.2	2.9	k Ω
Resistor ratio	R_1/R_2	0.042	0.047	0.052	-

AC Characteristics

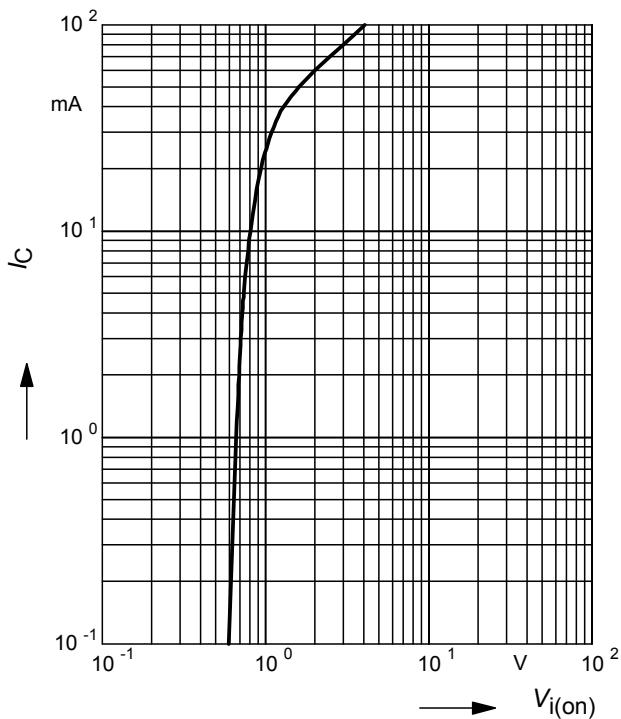
Transition frequency $I_C = 10 \text{ mA}, V_{CE} = 5 \text{ V}, f = 1 \text{ MHz}$	f_T	-	170	-	MHz
Collector-base capacitance $V_{CB} = 10 \text{ V}, f = 1 \text{ MHz}$	C_{cb}	-	2	-	pF

¹Pulse test: $t < 300\mu\text{s}$; D < 2%

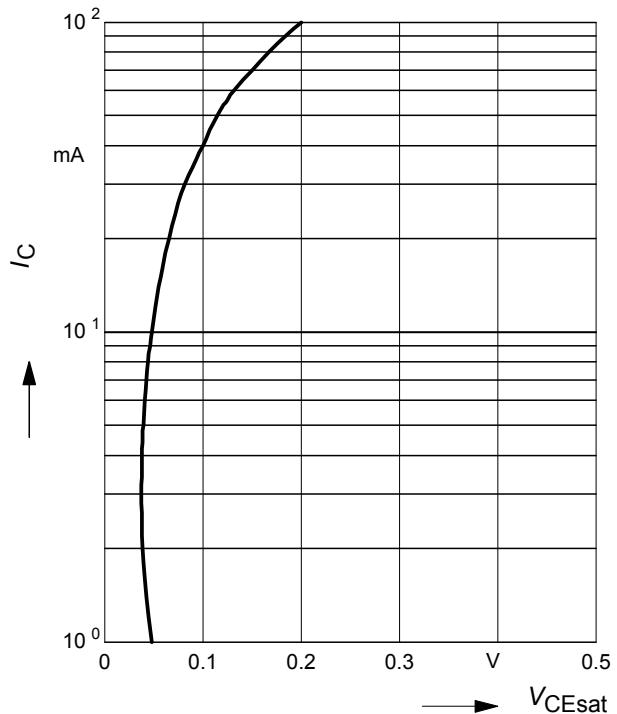
DC current gain $h_{FE} = f(I_C)$
 $V_{CE} = 5V$ (common emitter configuration)



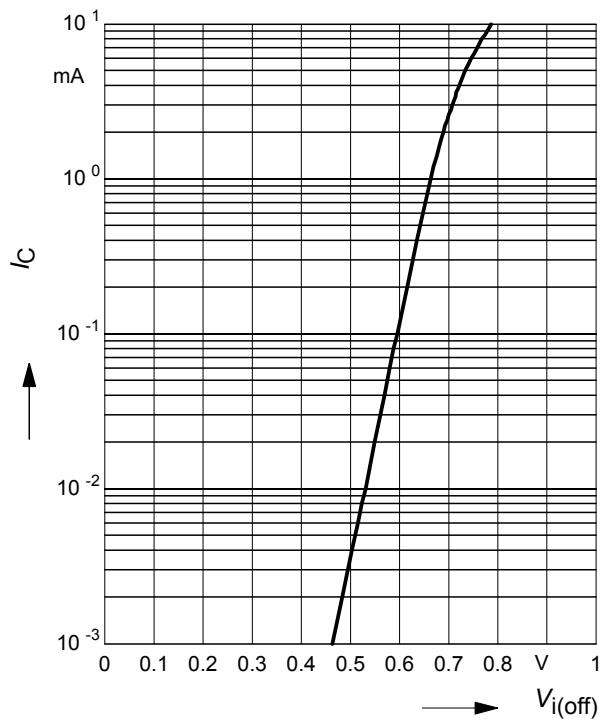
Input on Voltage $V_{i(on)} = f(I_C)$
 $V_{CE} = 0.3V$ (common emitter configuration)



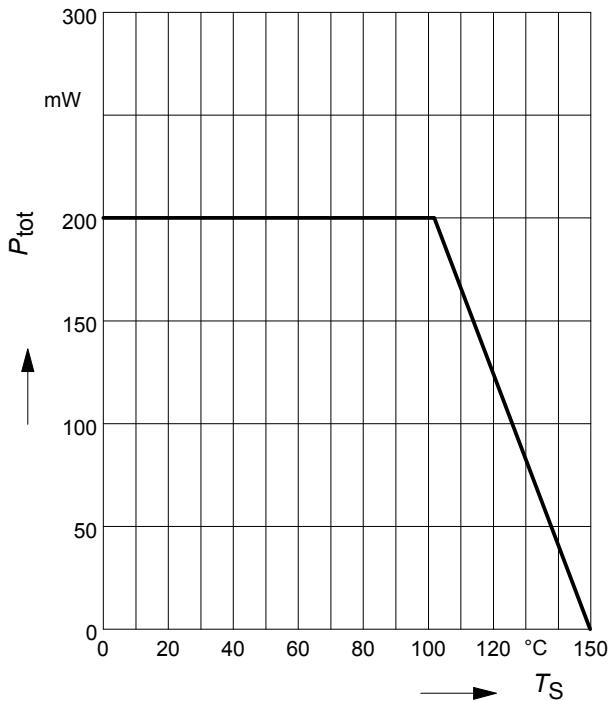
Collector-emitter saturation voltage
 $V_{CEsat} = f(I_C), h_{FE} = 20$



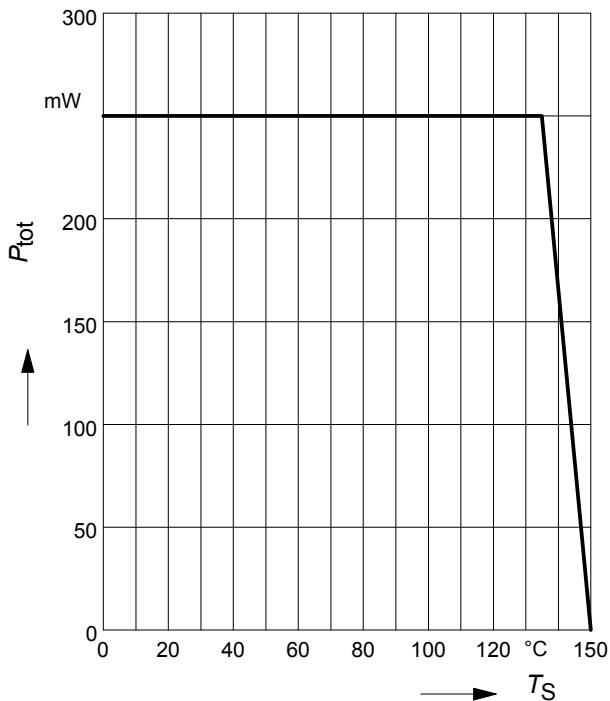
Input off voltage $V_{i(off)} = f(I_C)$
 $V_{CE} = 5V$ (common emitter configuration)



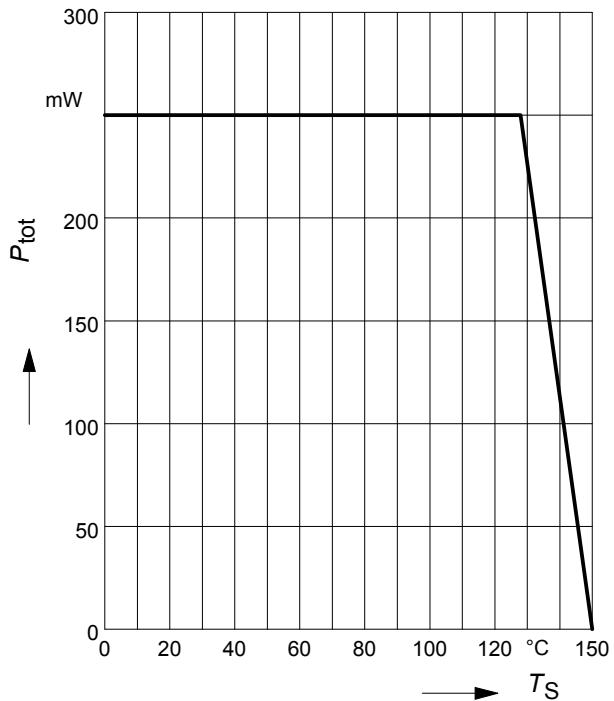
Total power dissipation $P_{\text{tot}} = f(T_S)$
BCR108



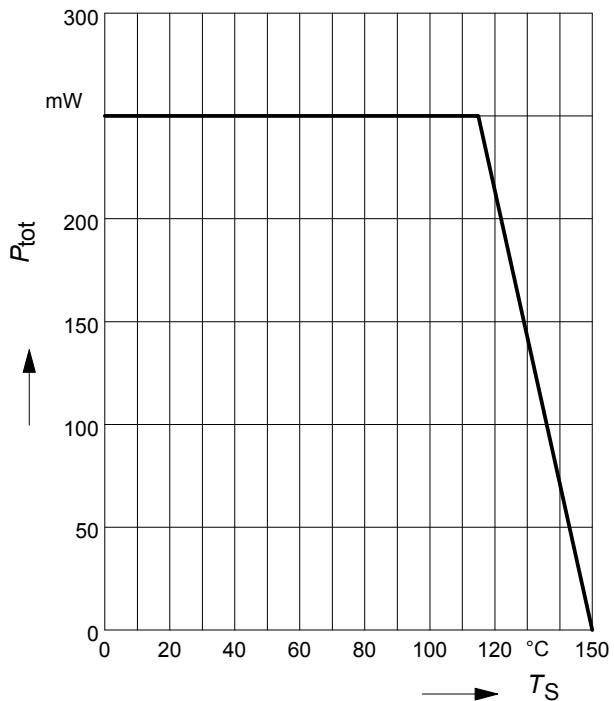
Total power dissipation $P_{\text{tot}} = f(T_S)$
BCR108L3



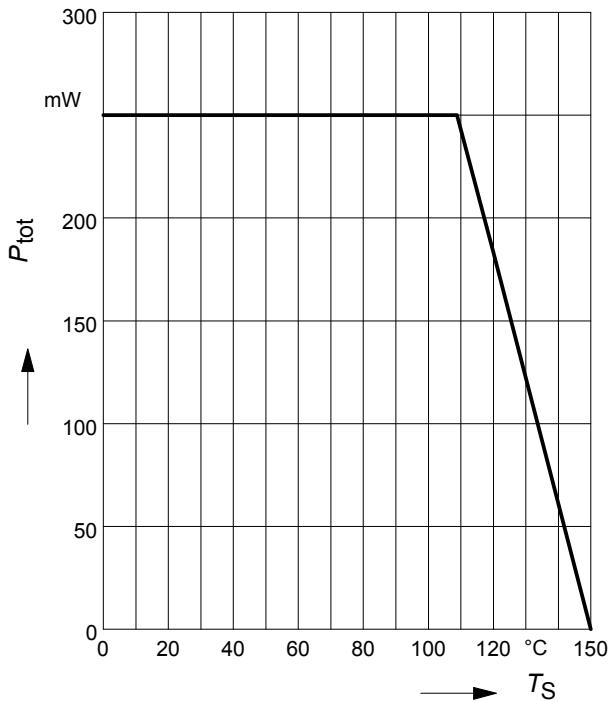
Total power dissipation $P_{\text{tot}} = f(T_S)$
BCR108F



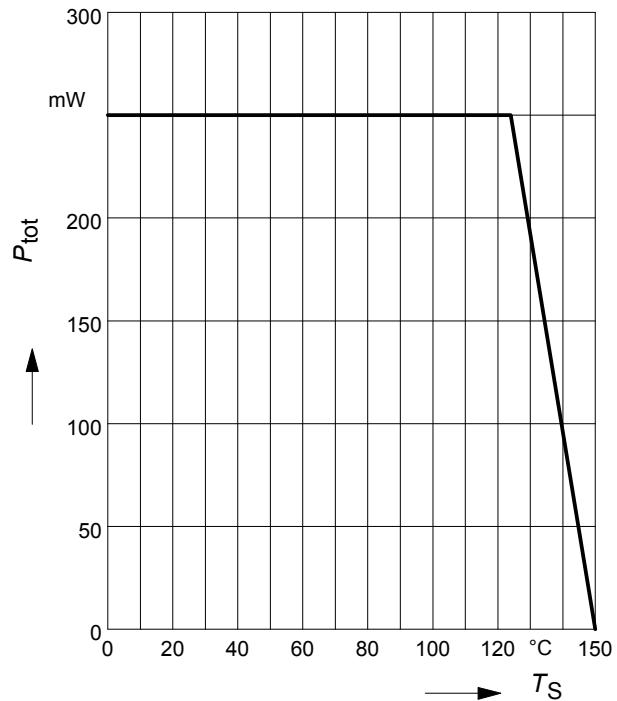
Total power dissipation $P_{\text{tot}} = f(T_S)$
BCR108S



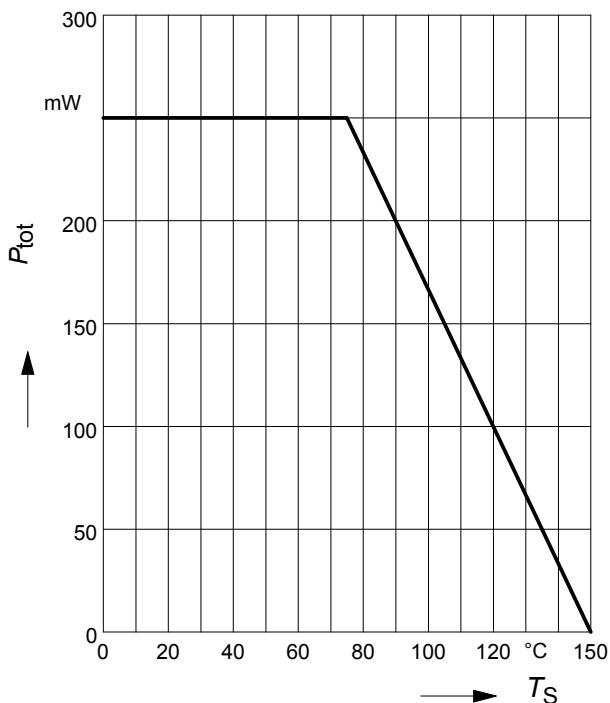
Total power dissipation $P_{\text{tot}} = f(T_S)$
BCR108T



Total power dissipation $P_{\text{tot}} = f(T_S)$
BCR108W

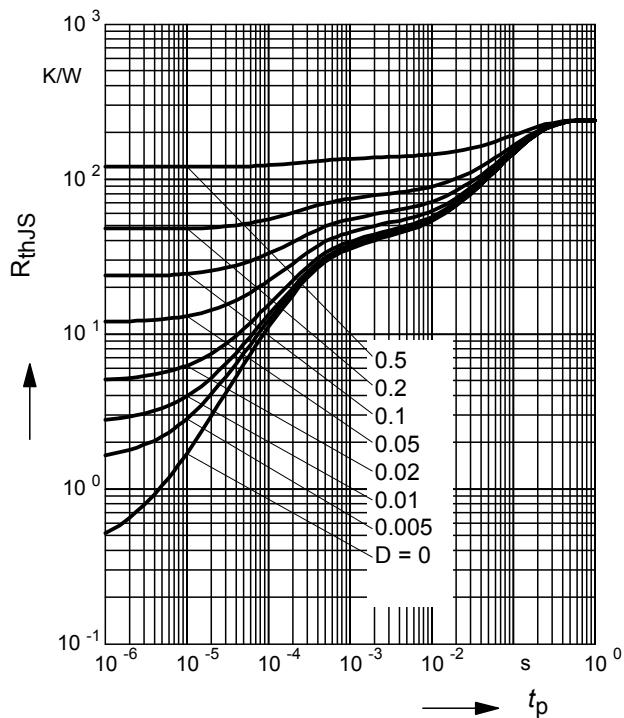


Total power dissipation $P_{\text{tot}} = f(T_S)$
SEMH10



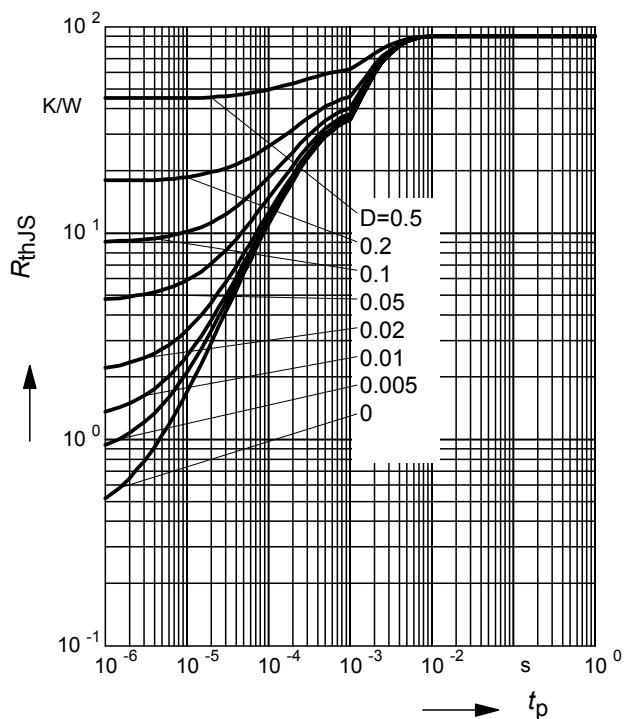
Permissible Pulse Load $R_{\text{thJS}} = f(t_p)$

BCR108



Permissible Pulse Load $R_{\text{thJS}} = f(t_p)$

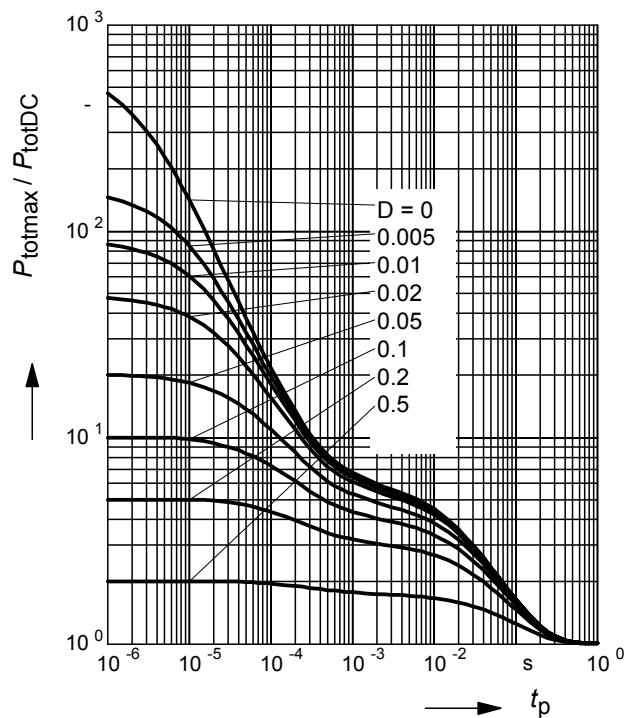
BCR108F



Permissible Pulse Load

$P_{\text{totmax}}/P_{\text{totDC}} = f(t_p)$

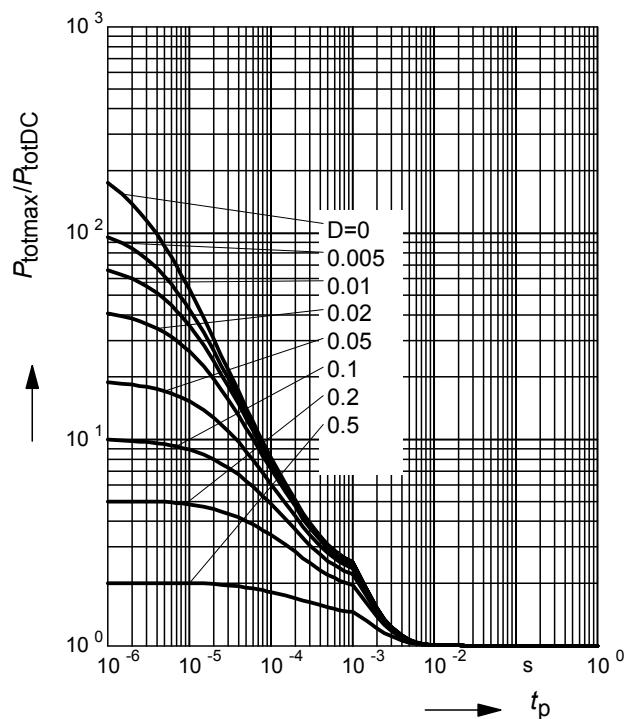
BCR108



Permissible Pulse Load

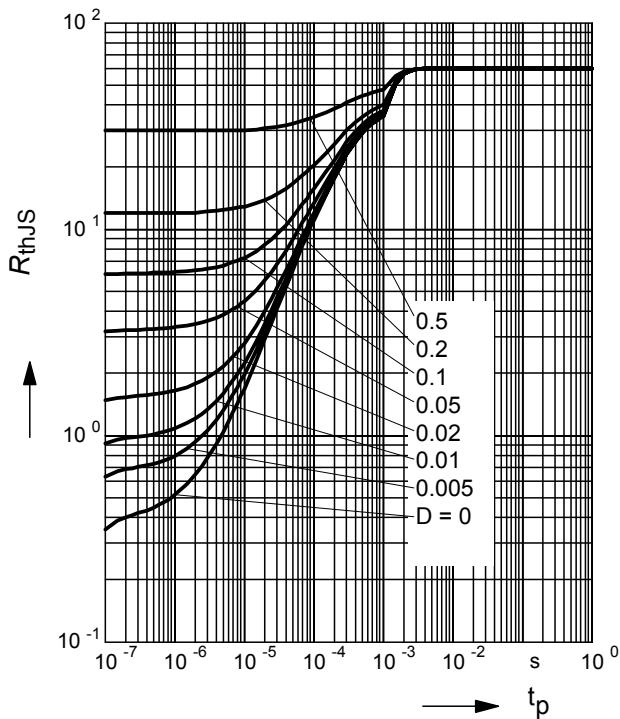
$P_{\text{totmax}}/P_{\text{totDC}} = f(t_p)$

BCR108F



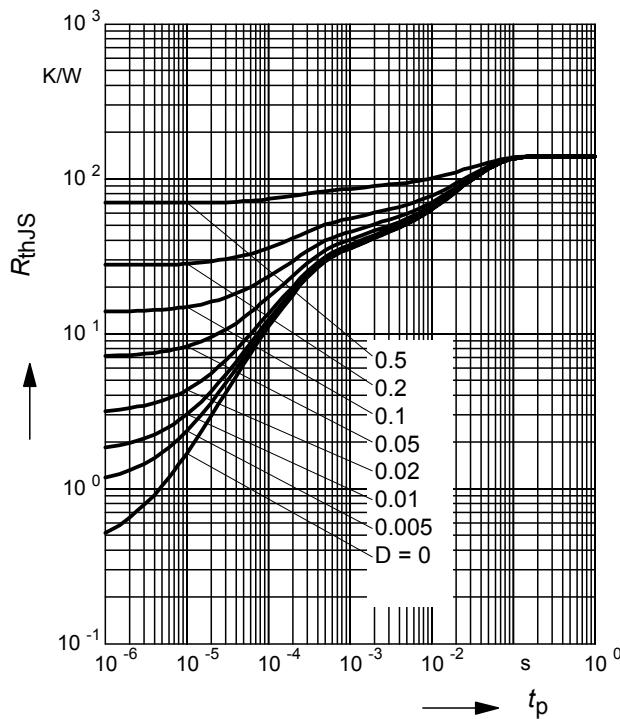
Permissible Puls Load $R_{\text{thJS}} = f(t_p)$

BCR108L3



Permissible Puls Load $R_{\text{thJS}} = f(t_p)$

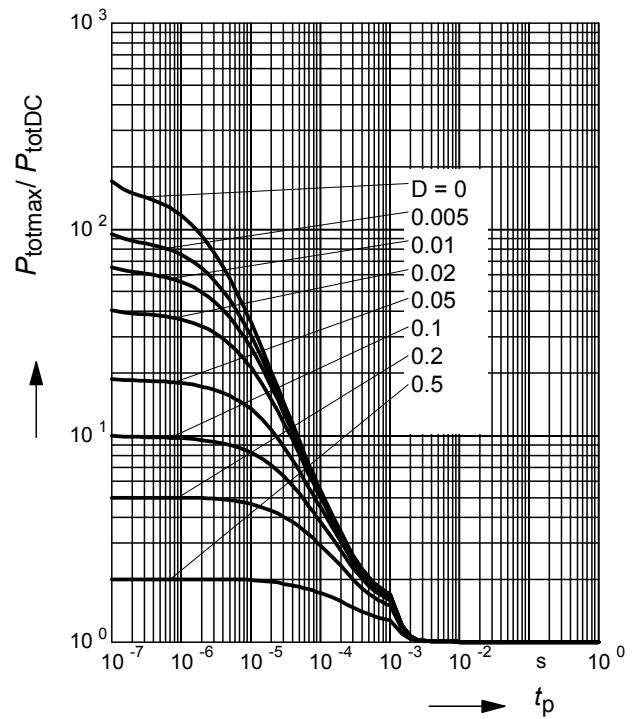
BCR108S



Permissible Pulse Load

$P_{\text{totmax}}/P_{\text{totDC}} = f(t_p)$

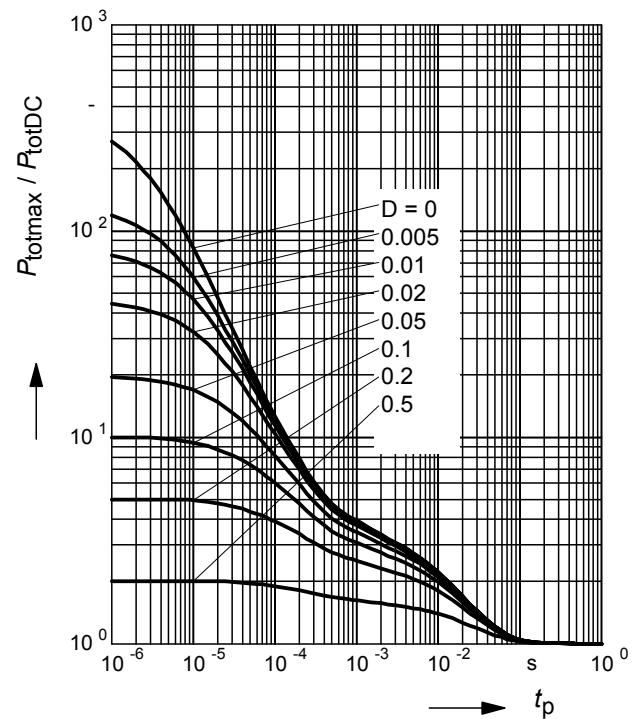
BCR108L3



Permissible Pulse Load

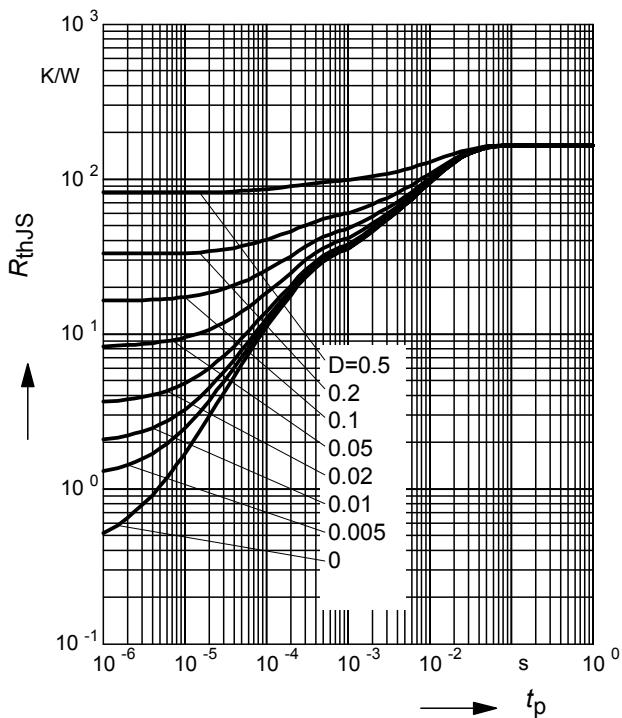
$P_{\text{totmax}}/P_{\text{totDC}} = f(t_p)$

BCR108S



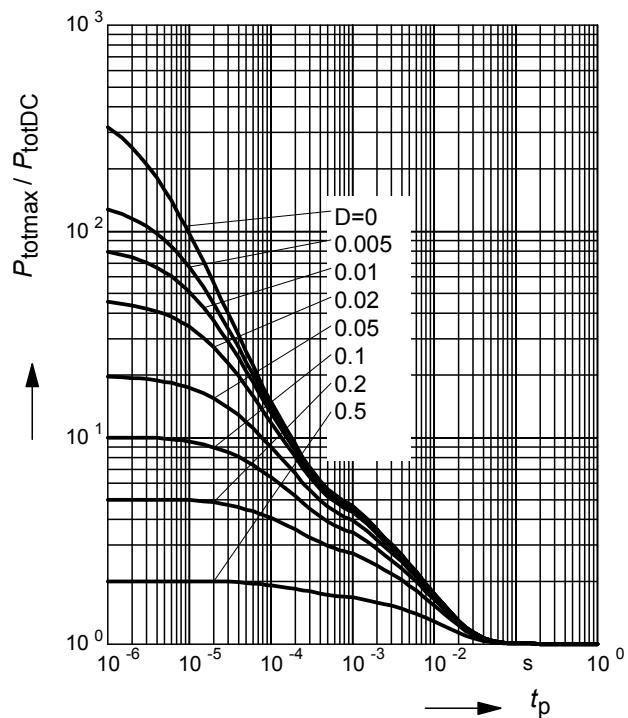
Permissible Puls Load $R_{\text{thJS}} = f(t_p)$

BCR108T

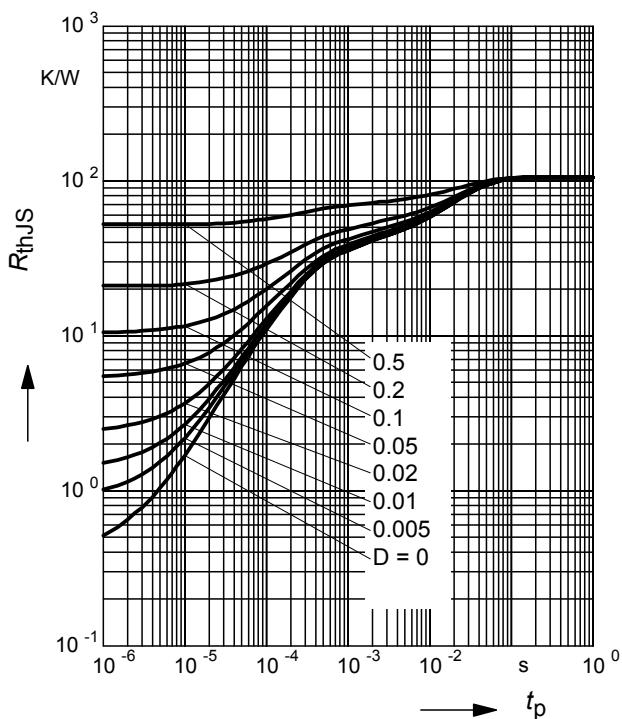

Permissible Pulse Load

$$P_{\text{totmax}}/P_{\text{totDC}} = f(t_p)$$

BCR108T

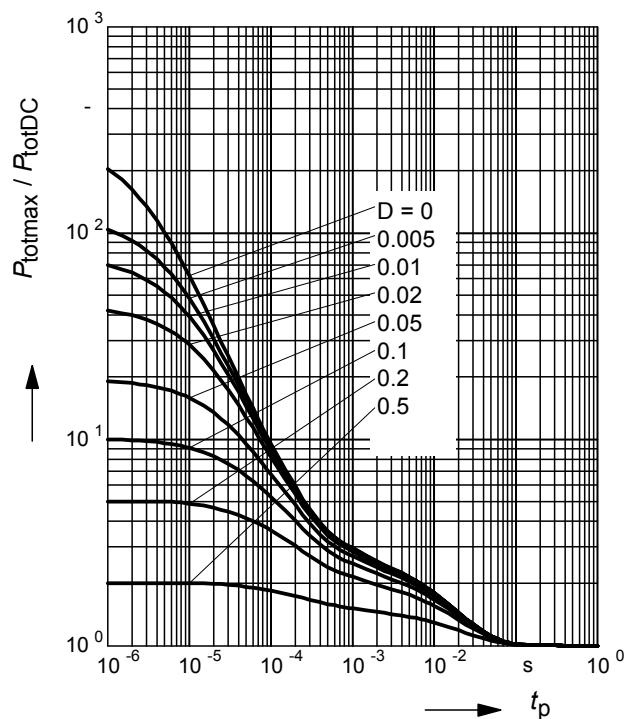

Permissible Puls Load $R_{\text{thJS}} = f(t_p)$

BCR108W


Permissible Pulse Load

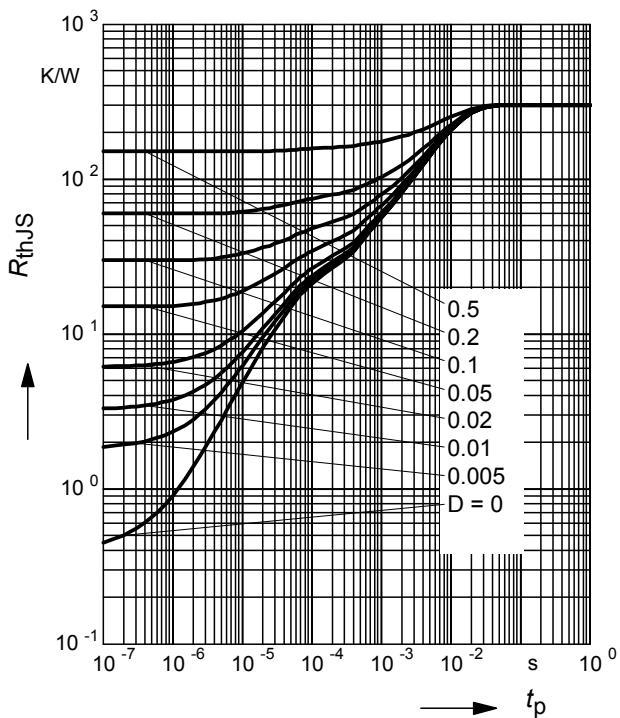
$$P_{\text{totmax}}/P_{\text{totDC}} = f(t_p)$$

BCR108W



Permissible Puls Load $R_{\text{thJS}} = f(t_p)$

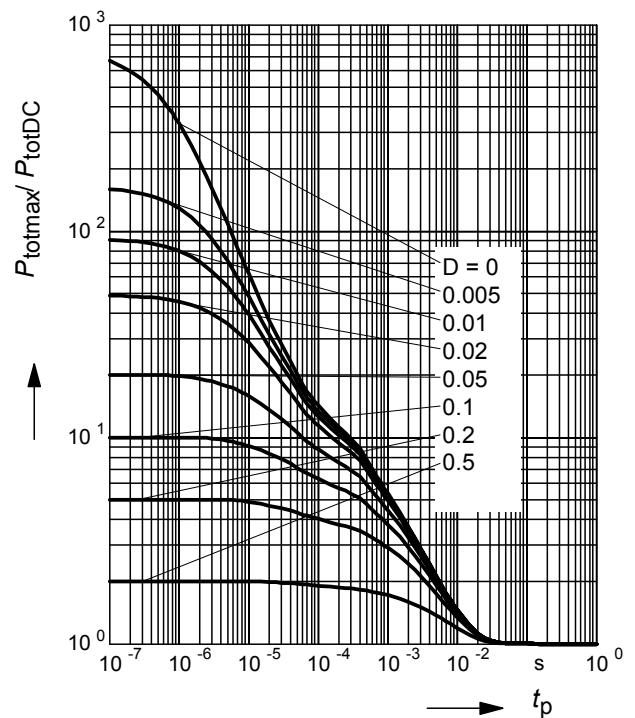
SEMH10



Permissible Pulse Load

$P_{\text{totmax}}/P_{\text{totDC}} = f(t_p)$

SEMH10



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